L Number	Hits	Search Text	DB	Time stamp
•	3160	ring adj oscillator	USPAT	2004/10/07 13:48
	2939	jtag "test access port" "1149.1" "scan chain"	USPAT	2004/10/07 13:52
	9	(ring adj oscillator) same (jtag "test access port" "1149.1" "scan chain")	USPAT	2004/10/07 13:56
	20	"speed binning"	USPAT	2004/10/07 13:59
	38	(ring adj oscillator) with wafer	USPAT	2004/10/07 14:01
	18	(jtag "test access port" "1149.1" "scan chain") with wafer	USPAT	2004/10/07 14:02
	36	(ring adj oscillator) and tdi	USPAT	2004/10/07 15:42
	10	(ring adj oscillator) same tdi	USPAT	2004/10/07 16:33
	21384	process adj (parameter metric)	USPAT	2004/10/08 14:26
.	22242	process near2 variation	USPAT	2004/10/08 14:2:
	101	(process adj (parameter metric)) same oscillator	USPAT	2004/10/08 14:23
	487	(process near2 variation) same oscillator	USPAT	2004/10/08 13:5
	52	8.ab.	USPAT	2004/10/08 14:18
	6	"62 19813 "	USPAT	2004/10/08 14:0
	12	5818250.URPN.	USPAT	2004/10/08 14:12
_	2	6463570.URPN.	USPAT	2004/10/08 14:13
_	22	8.clm.	USPAT	2004/10/08 14:18
	450	(sensitive sensitiz\$3) near2 oscillator	USPAT	2004/10/08 14:24
•	9	((sensitive sensitiz\$3) near2 oscillator) same ((process adj (parameter metric)) (process near2 variation))	USPAT	2004/10/08 14:2
	1	((sensitive sensitiz\$3) near2 oscillator) same (wafer die dice)	USPAT	2004/10/08 14:30
-	1340	process adj (parameter metric variation)	EPO; JPO;	2004/10/08 14:20
-	25	(process adj (parameter metric variation)) same oscillator	EPO; JPO; IBM_TDB	2004/10/08 14:29
-	16	test adj oscillator	EPO; JPO; IBM_TDB	2004/10/08 14:2
_	175	test adj oscillator	USPAT	2004/10/08 14:3
-	1	(test adj oscillator) same ((process adj (parameter metric)) (process near2 variation))	USPAT	2004/10/08 14:3
_	2	(test adj oscillator) same (wafer die dice)	USPAT	2004/10/08 14:3
	403	oscillator same (tdi tdo tms trst)	USPAT	2004/10/08 14:3
_	21	ring adj oscillator same (tdl tdo tms trst)	USPAT	2004/10/08 15:2
-	2	ring adj oscillator same (tdl tdo tms trst)	EPO; JPO; IBM_TDB	2004/10/08 14:3
-	82	oscillator same (tdl tdo tms trst)	EPO; JPO; IBM_TDB	2004/10/08 14:3
_	15	ring adj oscillator same (tck tclk)	USPAT	2004/10/08 14:3
-	7	ring adj oscillator same (jtag "test access port" "1149.1")	USPAT	2004/10/08 14:3
	42	ring adj oscillator and (jtag "test access port" "1149.1")	USPAT	2004/10/08 15:4
_	29	ring adj oscillator same scan	USPAT	2004/10/08 14:4
_	201	ring adj oscillator same chain	USPAT	2004/10/08 15:0
	25	46.clm.	USPAT	2004/10/08 14:5
_	148	ring adj oscillator with chain	USPAT	2004/10/08 14:5
_	14	46.ab.	USPAT	2004/10/08 14:5
	105	(enabl\$3 select\$3) near2 ring adj oscillator	USPAT	2004/10/08 15:1
	425	(enabl\$3 select\$3) near2 ro	USPAT	2004/10/08 15:1
	27	53.ab.	USPAT	2004/10/08 15:1
	808	(enabl\$3 select\$3) near2 (test adj2 circuit)	USPAT	2004/10/08 15:4
	45	((enabl\$3 select\$3) near2 (test adj2 circuit) ((enabl\$3 select\$3) near2 (test adj2 circuit)) and (jtag "test access port" "1149.1")	USPAT	2004/10/08 16:5
-	9	((enabl\$3 select\$3) near2 (test adj2 circuit)) same (tdl tdo tms trst)	USPAT	2004/10/08 15:2
	63443	(enabl\$3 select\$3) near2 (test structure)	USPAT	2004/10/08 15:4
_	7	ring adj oscillator and "tap controller"	USPAT	2004/10/08 15:4
•	205	((enabl\$3 select\$3) near2 (test structure)) same "tap controller"	USPAT	2004/10/08 15:4
-	504	((enabl\$3 select\$3) near2 (test structure)) same (jtag "test access port" "1149.1")	USPAT	2004/10/08 15:4

•	4	67.ab.	USPAT	2004/10/08 15:46
-	27	ring adj oscillator same test adj structure	USPAT	2004/10/08 15:47
-	1204	"scan chain"	USPAT	2004/10/08 18:03
	152	"scan chain" with "shift register"	USPAT	2004/10/08 18:02
	258	"shift register chain"	USPAT	2004/10/08 18:02
-	7	"shift register chain" with counter	USPAT	2004/10/08 18:03
	38	"scan chain" with counter	USPAT	2004/10/08 18:13
	5	"scan chain" with oscillator	USPAT	2004/10/08 18:13
	14	"scan chain" same oscillator	USPAT	2004/10/12 10:23